## FEATURES

High dynamic range
SNR $=\mathbf{7 5 . 0} \mathbf{~ d B F S}$ at $70 \mathrm{MHz}\left(\mathrm{A}_{\mathrm{IN}}=\mathbf{- 1} \mathbf{d B F S}\right)$
SFDR $=87 \mathrm{dBc}$ at $70 \mathrm{MHz}\left(\mathrm{A}_{\text {IN }}=\mathbf{- 1} \mathrm{dBFS}\right)$
Noise spectral density (NSD) $=\mathbf{- 1 5 6 . 7} \mathbf{d B F S} / \mathrm{Hz}$ input noise at $\mathbf{- 1} \mathbf{d B F S}$ at $70 \mathbf{~ M H z}$
NSD $=\mathbf{- 1 5 7 . 6} \mathbf{d B F S} / \mathrm{Hz}$ for small signal at $\mathbf{- 7} \mathbf{~ d B F S}$ at 70 MHz
90 dB channel isolation/crosstalk
On-chip dithering (improves small signal linearity)
Excellent IF sampling performance
SNR = $\mathbf{7 3 . 7} \mathbf{~ d B F S}$ at 170 MHz ( $A_{\text {IN }}=-1 \mathrm{dBFS}$ )
SFDR $=85 \mathrm{dBc}$ at $170 \mathrm{MHz}\left(\mathrm{A}_{\text {IN }}=-1 \mathrm{dBFS}\right)$
Full power bandwidth of $\mathbf{4 6 5} \mathbf{~ M H z}$
On-chip 3.3 V buffer
Programmable input span of 2 V p-p to 2.5 V p-p (default)
Differential clock input receiver with $1,2,4$, and 8 integer
inputs (clock divider input accepts up to 1.24 GHz )
Internal ADC clock duty cycle stabilizer
SYNC input allows multichip synchronization
Total power consumption: 2.16 W
3.3 V and 1.8 V supply voltages

DDR LVDS (ANSI-644 levels) outputs
Serial port control
Energy saving power-down modes

## APPLICATIONS

Military radar and communications
Multimode digital receivers (3G or 4G)
Test and instrumentation
Smart antenna systems

## GENERAL DESCRIPTION

The AD9652 is a dual, 16-bit analog-to-digital converter (ADC) with sampling speeds of up to 310 MSPS. It is designed to support demanding, high speed signal processing applications that require exceptional dynamic range over a wide input frequency range (up to 465 MHz ). Its exceptional low noise floor of -157.6 dBFS and large signal spurious-free dynamic range (SFDR) performance (exceeding 85 dBFS , typical) allows low level signals to be resolved in the presence of large signals.
The dual ADC cores feature a multistage, pipelined architecture with integrated output error correction logic. A high performance on-chip buffer and internal voltage reference simplify the interface to external driving circuitry while preserving the exceptional performance of the ADC.
The AD9652 can support input clock frequencies of up to 1.24 GHz with a $1,2,4$, and 8 integer clock divider to generate the ADC sample clock. A duty cycle stabilizer is provided to compensate for variations in the ADC clock duty cycle.

*THESE PINS ARE FOR CHANNEL A AND CHANNEL B.
Figure 1.

The 16-bit output data (with an overrange bit) from each ADC is interleaved onto a single LVDS output port along with a double data rate (DDR) clock. Programming for setup and control are accomplished using a 3-wire SPI-compatible serial interface.
The AD9652 is available in a 144 -ball CSP_BGA and is specified over the industrial temperature range of $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$. This product is protected by pending U.S. patents.

## PRODUCT HIGHLIGHTS

1. Integrated dual, 16-bit, 310 MSPS ADCs.
2. On-chip buffer simplifies ADC driver interface.
3. Operation from 3.3 V and 1.8 V supplies and a separate digital output driver supply accommodating LVDS outputs.
4. Proprietary differential input maintains excellent signal-tonoise ratio (SNR) performance for input frequencies of up to 485 MHz .
5. SYNC input allows synchronization of multiple devices.
6. Three-wire, 3.3 V or 1.8 V SPI port for register programming and readback.

One Technology Way, P.O. Box 9106, Norwood, MA 02062-9106, U.S.A. Tel: 781.329.4700 ©2014-2018 Analog Devices, Inc. All rights reserved. Technical Support www.analog.com

## AD9652

## TABLE OF CONTENTS

Features ..... 1
Applications ..... 1
Functional Block Diagram .....  1
General Description .....  1
Product Highlights .....  1
Revision History ..... 2
Specifications ..... 3
ADC DC Specifications ..... 3
ADC AC Specifications ..... 4
Digital Specifications ..... 5
Switching Specifications ..... 7
Timing Specifications ..... 7
Absolute Maximum Ratings ..... 9
Thermal Characteristics ..... 9
ESD Caution ..... 9
Pin Configuration and Function Descriptions ..... 10
Typical Performance Characteristics ..... 13
Equivalent Circuits ..... 19
Theory of Operation ..... 20
ADC Architecture ..... 20
Analog Input Considerations ..... 20
REVISION HISTORY
1/2018—Rev. B to Rev. C
Changes to Transfer Register Map Section ..... 31
Changes to Table 17 ..... 34
Changes to Ordering Guide ..... 36
1/2017—Rev. A to Rev. B
Changes to DCO $\pm$ to Data Skew (tskew) Parameter, Table 4 .....  7
Changes to Clock Input Options Section ..... 24
Voltage Reference ..... 23
Clock Input Considerations ..... 23
Power Dissipation and Standby Mode ..... 25
Internal Background Calibration ..... 25
Digital Outputs ..... 26
ADC Overrange ..... 26
Fast Threshold Detection (FDA/FDB) ..... 28
Serial Port Interface. ..... 29
Configuration Using the SPI ..... 29
Hardware Interface ..... 29
Configuration Without the SPI ..... 29
SPI Accessible Features ..... 30
Memory Map ..... 31
Reading the Memory Map Register Table ..... 31
Memory Map Register Table ..... 32
Applications Information ..... 35
Design Guidelines ..... 35
Outline Dimensions ..... 36
Ordering Guide ..... 36
5/2014—Rev. 0 to Rev. A
Changes to Supply Current, Clock Divider = 1 Parameter and Power Consumption, Clock Divider $=1$ Parameter, Table 1 . 3
4/2014-Revision 0: Initial Version

4/2014—Revision 0: Initial Version

AD9652

## SPECIFICATIONS

## ADC DC SPECIFICATIONS

AVDD3 $=3.3 \mathrm{~V}, \mathrm{AVDD}=\mathrm{AVDD} \_\mathrm{CLK}=1.8 \mathrm{~V}, \mathrm{SPIVDD}=\mathrm{DRVDD}=1.8 \mathrm{~V}$, sample rate $=310 \mathrm{MSPS}$ (clock input $=1240 \mathrm{MHz}, \mathrm{AD} 9652$ divided by 4 ), VIN $=-1.0 \mathrm{dBFS}$ differential input, 2.5 V p-p full-scale input range, duty cycle stabilizer (DCS) enabled, dither disabled, unless otherwise noted.

Table 1.

| Parameter | Temperature | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| RESOLUTION | Full |  | 16 |  | Bits |
| ACCURACY <br> No Missing Codes <br> Offset Error <br> Gain Error <br> Differential Nonlinearity (DNL) ${ }^{1}$ <br> Integral Nonlinearity (INL) ${ }^{1}$ | Full <br> Full <br> Full <br> Full <br> Full |  | $\begin{aligned} & \text { Guaranteed } \\ & 1.5 \\ & -0.3 \\ & -0.76 /+1.1 \\ & -4.5 /+4.5 \\ & \hline \end{aligned}$ |  | $\begin{aligned} & \mathrm{mV} \\ & \% \text { FSR } \\ & \text { LSB } \\ & \text { LSB } \end{aligned}$ |
| MATCHING CHARACTERISTIC Offset Error Gain Error | Full Full |  | $\begin{aligned} & \pm 0.7 \\ & \pm 0.1 \end{aligned}$ |  | $\begin{aligned} & \mathrm{mV} \\ & \% F S R \end{aligned}$ |
| TEMPERATURE DRIFT <br> Offset Error <br> Gain Error | Full Full |  | $\begin{aligned} & \pm 0.8 \\ & \pm 16 \end{aligned}$ |  | ppm $/{ }^{\circ} \mathrm{C}$ $\mathrm{ppm} /{ }^{\circ} \mathrm{C}$ |
| INPUT REFERRED NOISE $V_{\text {REF }}=1.25 \mathrm{~V}$ | $25^{\circ} \mathrm{C}$ |  | 3.7 |  | LSB rms |
| ANALOG INPUT <br> Input Span (for $\mathrm{V}_{\text {REF }}=1.25 \mathrm{~V}$ ) <br> Input Capacitance ${ }^{2}$ <br> Input Resistance ${ }^{3}$ <br> Input Common-Mode Voltage | Full <br> Full <br> Full <br> Full |  | $\begin{aligned} & 2.5 \\ & 5.8 \\ & 27 \\ & 2.0 \end{aligned}$ | 2.4 | $\begin{aligned} & \mathrm{V} p-\mathrm{p} \\ & \mathrm{pF} \\ & \mathrm{k} \Omega \\ & \mathrm{~V} \end{aligned}$ |
| POWER SUPPLIES <br> Supply Voltage <br> AVDD3 <br> AVDD <br> AVDD_CLK <br> DRVDD <br> SPIVDD <br> Supply Current, Clock Divider = 1 <br> Iavdd <br> lavdo <br> lavdd_clk <br> IdrvDD <br> IspivD | Full <br> Full <br> Full <br> Full <br> Full <br> Full <br> Full <br> Full <br> Full <br> Full | $\begin{aligned} & 3.15 \\ & 1.7 \\ & 1.7 \\ & 1.7 \\ & 1.7 \end{aligned}$ | $\begin{aligned} & 3.3 \\ & 1.8 \\ & 1.8 \\ & 1.8 \\ & 1.8 \\ & \\ & 145 \\ & 701 \\ & 56 \\ & 180 \\ & 0.005 \end{aligned}$ | $\begin{aligned} & 3.45 \\ & 1.9 \\ & 1.9 \\ & 1.9 \\ & 3.6 \end{aligned}$ |  |
| POWER CONSUMPTION <br> Clock Divider = 1 <br> Normal Operation ${ }^{1}$ <br> Standby Power ${ }^{4}$ <br> Power-Down Power | Full <br> Full <br> Full |  | $\begin{aligned} & 2160 \\ & 80 \\ & 1 \end{aligned}$ | 2236 | mW <br> mW <br> mW |

[^0]
## AD9652

## ADC AC SPECIFICATIONS

AVDD3 $=3.3 \mathrm{~V}, \mathrm{AVDD}=\mathrm{AVDD} \_\mathrm{CLK}=1.8 \mathrm{~V}, \mathrm{SPIVDD}=\mathrm{DRVDD}=1.8 \mathrm{~V}$, sample rate $=310 \mathrm{MSPS}$ (clock input $=1240 \mathrm{MHz}, \mathrm{AD9652}$ divided by 4 ), VIN $=-1.0 \mathrm{dBFS}$ differential input, 2.5 V p-p full-scale input range, DCS enabled, dither disabled, unless otherwise noted.

Table 2.

| Parameter ${ }^{1}$ | Temperature | $\mathrm{V}_{\text {Ref }}=1 \mathrm{~V}$ |  |  | $\mathrm{V}_{\text {REF }}=1.25 \mathrm{~V}$, Default |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max |  |
| DIFFERENTIAL INPUT VOLTAGE | $25^{\circ} \mathrm{C}$ |  | 2.0 |  |  | 2.5 |  | Vp-p |
| SIGNAL-TO-NOISE RATIO (SNR) |  |  |  |  |  |  |  |  |
| $\mathrm{ff}_{\mathrm{IN}}=30 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | 74.0 |  |  | 75.4 |  | dBFS |
| $\mathrm{fiN}^{\text {a }}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | 73.6 |  | 74.0 | 75.0 |  | dBFS |
|  | Full |  |  |  | 73.3 |  |  | dBFS |
| $\mathrm{fiN}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings, with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | 73.1 |  |  | 74.3 |  | dBFS |
| $\mathrm{fiN}^{\prime}=170 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  | 72.1 |  |  | 73.7 |  | dBFS |
| $\mathrm{ffin}^{\prime}=170 \mathrm{MHz}$ (Use Nyquist 2 Settings, with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | 71.2 |  |  | 72.0 |  | dBFS |
| $\mathrm{fiN}_{\text {I }}=305 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  | 70.1 |  |  | 70.7 |  | dBFS |
| $\mathrm{fiN}_{\text {I }}=400 \mathrm{MHz}$ (Use Nyquist 3 Settings) | $25^{\circ} \mathrm{C}$ |  | 67.9 |  |  | 68.0 |  | dBFS |
| SIGNAL-TO-NOISE AND DISTORTION (SINAD) |  |  |  |  |  |  |  |  |
| $\mathrm{fiN}_{\mathrm{IN}}=30 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | 72.8 |  |  | 74.2 |  | dBFS |
| $\mathrm{ff}_{\mathrm{IN}}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | 73.5 |  | 73.8 | 74.6 |  | dBFS |
|  | Full |  |  |  | 73.2 |  |  | dBFS |
| $\mathrm{fin}_{\text {in }}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings, with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | 73.0 |  |  | 74.0 |  | dBFS |
| $\mathrm{fiN}^{\text {a }}=170 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  | 72.0 |  |  | 72.6 |  | dBFS |
| $\mathrm{fin}^{\prime}=170 \mathrm{MHz}$ (Use Nyquist 2 Settings, with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | 71.1 |  |  | 71.7 |  | dBFS |
| $\mathrm{fiN}_{\text {I }}=305 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  |  |  |  | 68.5 |  | dBFS |
| $\mathrm{fiN}_{\text {N }}=400 \mathrm{MHz}$ (Use Nyquist 3 Settings) | $25^{\circ} \mathrm{C}$ |  |  |  |  | 65.8 |  | dBFS |
| EFFECTIVE NUMBER OF BITS (ENOB) |  |  |  |  |  |  |  |  |
| $\mathrm{fiN}_{\mathrm{I}}=30 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | 11.8 |  |  | 12.0 |  | Bits |
| $\mathrm{fiN}_{\mathrm{I}}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | 12 |  | 12.0 | 12.1 |  | Bits |
|  | Full |  |  |  | 11.9 |  |  | Bits |
| $\mathrm{fiN}_{\text {I }}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings, with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | 11.8 |  |  | 12.0 |  | Bits |
| $\mathrm{fiN}^{\text {= }} 170 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  | 11.7 |  |  | 11.8 |  | Bits |
| $\mathrm{fiN}_{\text {i }}=170 \mathrm{MHz}$ (Use Nyquist 2 Settings, with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | 11.5 |  |  | 11.6 |  | Bits |
| $\mathrm{fiN}_{\text {I }}=305 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  |  |  |  | 11.1 |  | Bits |
| $\mathrm{fiN}_{\text {I }}=400 \mathrm{MHz}$ (Use Nyquist 3 Settings) | $25^{\circ} \mathrm{C}$ |  |  |  |  | 10.6 |  | Bits |
| WORST SECOND OR THIRD HARMONIC |  |  |  |  |  |  |  |  |
| $\mathrm{ff}_{\mathrm{N}}=30 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | -96 |  |  | -94 |  | dBc |
| $\mathrm{fiN}_{\mathrm{I}}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | -90 |  |  | -87 | -83 | dBc |
|  | Full |  |  |  |  |  | -83 | dBC |
| $\mathrm{fin}^{\text {( }}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings, with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | -92 |  |  | -89 |  | dBC |
| $\mathrm{fiN}^{\text {a }}=170 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  | -87 |  |  | -85 |  | dBC |
| $\mathrm{fin}^{\prime}=170 \mathrm{MHz}$ (Use Nyquist 2 Settings, with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | -87 |  |  | -85 |  | dBc |
| $\mathrm{fiN}_{\text {I }}=305 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  | -89 |  |  | -86 |  | dBc |
| $\mathrm{fiN}_{\text {N }}=400 \mathrm{MHz}$ (Use Nyquist 3 Settings) | $25^{\circ} \mathrm{C}$ |  | -80 |  |  | -77 |  | dBc |
| SPURIOUS-FREE DYNAMIC RANGE (SFDR) |  |  |  |  |  |  |  |  |
| $\mathrm{ff}_{\mathrm{IN}}=30 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | 96 |  |  | 94 |  | dBC |
| $\mathrm{fiN}_{\mathrm{IN}}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | 90 |  | 83 | 87 |  | dBc |
|  | Full |  |  |  | 83 |  |  | dBc |
| $\mathrm{fin}_{\text {I }}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings. with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | 92 |  |  | 89 |  | dBC |
| $\mathrm{fiN}_{\text {I }}=170 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  | 84 |  |  | 85 |  | dBc |
| $\mathrm{fiN}^{\text {}}=170 \mathrm{MHz}$ (Use Nyquist 2 Settings, with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | 87 |  |  | 85 |  | dBc |
| $\mathrm{fiN}_{\text {I }}=305 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  | 89 |  |  | 86 |  | dBc |
| $\mathrm{fiN}_{\text {I }}=400 \mathrm{MHz}$ (Use Nyquist 3 Settings) | $25^{\circ} \mathrm{C}$ |  | 80 |  |  | 77 |  | dBc |


| Parameter ${ }^{1}$ | Temperature | $\mathrm{V}_{\text {REF }}=1 \mathrm{~V}$ |  |  | $\mathrm{V}_{\text {REF }}=1.25 \mathrm{~V}$, Default |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max |  |
| WORST OTHER (NOT INCLUDING $2^{\text {nd }}$ or $3{ }^{\text {rd }}$ HARMONIC) |  |  |  |  |  |  |  |  |
| $\mathrm{fiN}_{\text {IN }}=30 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | -101 |  |  | -102 |  | dBc |
| $\mathrm{fiN}_{\text {I }}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings) | $25^{\circ} \mathrm{C}$ |  | -99 |  |  | -98 | -90 | dBC |
|  | Full |  |  |  |  |  | -86 | dBC |
| $\mathrm{fiN}_{\mathrm{N}}=70 \mathrm{MHz}$ (Use Nyquist 1 Settings, with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | -100 |  |  | -100 |  | dBC |
| $\mathrm{fiN}_{\text {I }}=170 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  | -91 |  |  | -90 |  | dBc |
| $\mathrm{ff}_{\mathrm{IN}}=170 \mathrm{MHz}$ (Use Nyquist 2 Settings, with Dither Enabled) | $25^{\circ} \mathrm{C}$ |  | -90 |  |  | -95 |  | dBC |
| $\mathrm{fiN}_{\text {I }}=305 \mathrm{MHz}$ (Use Nyquist 2 Settings) | $25^{\circ} \mathrm{C}$ |  | -98 |  |  | -97 |  | dBC |
| $\mathrm{fiN}^{\prime}=400 \mathrm{MHz}$ (Use Nyquist 3 Settings) | $25^{\circ} \mathrm{C}$ |  | -92 |  |  | -91 |  | dBc |
| TWO-TONE SFDR |  |  |  |  |  |  |  |  |
| $\mathrm{fin}_{\mathrm{N}}=70.1 \mathrm{MHz}(-7 \mathrm{dBFS}), 72.1 \mathrm{MHz}(-7 \mathrm{dBFS})$ | $25^{\circ} \mathrm{C}$ |  |  |  |  | 93 |  | dBc |
| $\mathrm{f}_{\mathrm{IN}}=184.12 \mathrm{MHz}(-7 \mathrm{dBFS}), 187.12 \mathrm{MHz}(-7 \mathrm{dBFS})$ | $25^{\circ} \mathrm{C}$ |  |  |  |  | 83 |  | dBC |
| CROSSTALK ${ }^{2}$ | Full |  | 90 |  |  | 90 |  | dB |
| FULL POWER BANDWIDTH ${ }^{3}$ | $25^{\circ} \mathrm{C}$ |  | 485 |  |  | 485 |  | MHz |
| NOISE BANDWIDTH ${ }^{4}$ | $25^{\circ} \mathrm{C}$ |  | 650 |  |  | 650 |  | MHz |

${ }^{1}$ See the AN-835 Application Note, Understanding High Speed ADC Testing and Evaluation, for a complete set of definitions.
${ }^{2}$ Crosstalk is measured at 100 MHz with -1.0 dBFS on one channel and no input on the alternate channel.
${ }^{3}$ Full power bandwidth is the bandwidth of operation in which proper ADC performance can be achieved.
${ }^{4}$ Noise bandwidth is the -3 dB bandwidth for the ADC inputs across which noise can enter the ADC and is not attenuated internally.

## DIGITAL SPECIFICATIONS

AVDD3 $=3.3 \mathrm{~V}, \mathrm{AVDD}=\mathrm{AVDD} \_\mathrm{CLK}=1.8 \mathrm{~V}, \mathrm{SPIVDD}=\mathrm{DRVDD}=1.8 \mathrm{~V}$, sample rate $=310 \mathrm{MSPS}$ (clock input $=1240 \mathrm{MHz}$, AD9652 divided by 4 ), VIN $=-1.0 \mathrm{dBFS}$ differential input, 2.5 V p-p full-scale input range, DCS enabled, dither disabled, unless otherwise noted.
Table 3.

| Parameter | Test Conditions/Comments | Temperature | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DIFFERENTIAL CLOCK INPUTS (CLK+, CLK-) |  |  |  |  |  |  |
| Logic Compliance |  |  | CMOS/LVDS/LVPECL |  |  |  |
| Differential Input Voltage |  | Full | 0.3 |  | 3.6 | Vp-p |
| Input Voltage Range |  | Full | AGND |  | AVDD_CLK | V |
| Internal Common-Mode Bias |  | Full | 0.9 |  |  | V |
| Input Common-Mode Range |  | Full | 0.9 |  | 1.4 | V |
| High Level Input Current |  | Full | +10 |  | +145 | $\mu \mathrm{A}$ |
| Low Level Input Current |  | Full | -155 |  | -15 | $\mu \mathrm{A}$ |
| Input Capacitance ${ }^{1}$ |  | Full | 5 |  |  | pF |
| Input Resistance ${ }^{1}$ |  | Full | 10 |  |  | $\mathrm{k} \Omega$ |
| SYNC INPUT |  |  |  |  |  |  |
| Logic Compliance |  |  | CMOS/LVDS |  |  |  |
| Internal Bias |  | Full | 0.9 |  |  | V |
| Input Voltage Range |  | Full | AGND |  | AVDD_CLK | V |
| High Level Input Voltage |  | Full | 1.2 |  | AVDD_CLK | V |
| Low Level Input Voltage |  | Full | AGND |  | 0.6 | V |
| High Level Input Current |  | Full | -15 |  | +110 | $\mu \mathrm{A}$ |
| Low Level Input Current |  | Full | -105 |  | +15 | $\mu \mathrm{A}$ |
| Input Capacitance |  | Full |  | 1.5 |  | pF |
| Input Resistance |  | Full |  | 16 |  | $\mathrm{k} \Omega$ |


| Parameter | Test Conditions/Comments | Temperature | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| LOGIC INPUT (CSB) ${ }^{2}$ <br> High Level Input Voltage Low Level Input Voltage High Level Input Current Low Level Input Current Input Resistance Input Capacitance |  | Full <br> Full <br> Full <br> Full <br> Full <br> Full | $\begin{aligned} & 1.22 \\ & 0 \\ & -65 \\ & -135 \end{aligned}$ | $\begin{aligned} & 26 \\ & 2 \end{aligned}$ | $\begin{aligned} & \text { SPIVDD } \\ & 0.6 \\ & +65 \\ & 0 \end{aligned}$ | V <br> V <br> $\mu \mathrm{A}$ <br> $\mu \mathrm{A}$ <br> $k \Omega$ <br> pF |
| LOGIC INPUT (SCLK) ${ }^{3}$ <br> High Level Input Voltage Low Level Input Voltage High Level Input Current Low Level Input Current Input Resistance Input Capacitance |  | Full <br> Full <br> Full <br> Full <br> Full <br> Full | $\begin{aligned} & 1.22 \\ & 0 \\ & 0 \\ & -60 \end{aligned}$ | $\begin{aligned} & 26 \\ & 2 \end{aligned}$ | $\begin{aligned} & \text { SPIVDD } \\ & 0.6 \\ & 110 \\ & +50 \\ & \\ & \hline \end{aligned}$ | V <br> V <br> $\mu \mathrm{A}$ <br> $\mu \mathrm{A}$ <br> k $\Omega$ <br> pF |
| LOGIC INPUTS (SDIO) ${ }^{2}$ <br> High Level Input Voltage Low Level Input Voltage High Level Input Current Low Level Input Current Input Resistance Input Capacitance |  | Full <br> Full <br> Full <br> Full <br> Full <br> Full | $\begin{aligned} & 1.22 \\ & 0 \\ & -65 \\ & -135 \end{aligned}$ | $\begin{aligned} & 26 \\ & 5 \end{aligned}$ | $\begin{aligned} & \text { SPIVDD } \\ & 0.6 \\ & +70 \\ & 0 \end{aligned}$ | V <br> V <br> $\mu \mathrm{A}$ <br> $\mu \mathrm{A}$ <br> $\mathrm{k} \Omega$ <br> pF |
| LOGIC INPUTS (PDWN) ${ }^{3}$ <br> High Level Input Voltage Low Level Input Voltage High Level Input Current Low Level Input Current Input Resistance Input Capacitance |  | Full <br> Full <br> Full <br> Full <br> Full <br> Full | $\begin{aligned} & 1.22 \\ & 0 \\ & -80 \\ & -145 \end{aligned}$ | $\begin{aligned} & 26 \\ & 5 \end{aligned}$ | $\begin{aligned} & \text { DRVDD } \\ & 0.6 \\ & +190 \\ & +130 \end{aligned}$ | V <br> V <br> $\mu \mathrm{A}$ <br> $\mu \mathrm{A}$ <br> k $\Omega$ <br> pF |
| DIGITAL OUTPUTS <br> LVDS Data and OR $\pm$ Outputs <br> ANSI Mode <br> Differential Output Voltage (Vod) <br> Output Offset Voltage (Vos) <br> Reduced Swing Mode Differential Output Voltage (Vod) <br> Output Offset Voltage (Vos) | Assumes nominal $100 \Omega$ differential termination <br> Maximum setting, default <br> Minimum setting | Full <br> Full <br> Full <br> Full | $\begin{aligned} & 310 \\ & 1.15 \\ & 150 \\ & 1.15 \end{aligned}$ | 350 <br> 1.22 <br> 200 <br> 1.22 | 450 <br> 1.35 <br> 280 <br> 1.35 | mV <br> V <br> mV <br> V |

[^1]AD9652

## SWITCHING SPECIFICATIONS

Table 4.

| Parameter | Test Conditions/Comments | Temperature | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CLOCK INPUT PARAMETERS (CLK $\pm$ ) |  |  |  |  |  |  |
| Input Clock Rate |  | Full | 80 |  | 1240 | MHz |
| Conversion Rate ${ }^{1}$ |  | Full | 80 |  | 310 | MSPS |
| Period—Divide by 1 Mode (tcık) |  | Full | 3.2 |  |  | ns |
| Pulse Width High ( $\mathrm{tch}^{\text {) }}$, Minimum |  |  |  |  |  |  |
| Divide by 1 Mode | DCS enabled | Full |  | 0.8 |  | ns |
|  | DCS disabled | Full |  | 1.3 |  |  |
| Divide by 2 Mode Through Divide by 8 Mode |  | Full |  | 0.8 |  |  |
| Aperture Delay ( $\mathrm{t}_{\mathrm{A}}$ ) |  | Full |  | 1.0 |  |  |
| Aperture Uncertainty (Jitter, t ) |  | Full |  | 0.1 |  | ps rms |
| DATA OUTPUT PARAMETERS |  |  |  |  |  |  |
| LVDS Mode |  |  |  |  |  |  |
| Data Propagation Delay ( $\mathrm{tpD}^{\text {) }}$ |  | Full |  | 290 |  | ps |
| DCO $\pm$ Propagation Delay (toco) |  | Full |  | 290 |  | ps |
| DCO $\pm$ to Data Skew (tskew) |  | Full | -80 | -280 | -480 | ps ${ }^{2}$ |
| Pipeline Delay (Latency) |  | Full |  | 26 |  | Cycles |
| Wake-Up Time | From standby | Full |  | 100 |  | $\mu \mathrm{s}$ |
|  | From power-down | Full |  | 1 |  | sec |
| Out of Range Recovery Time |  | Full |  | 3 |  | Cycles |

${ }^{1}$ Conversion rate is the clock rate after the divider.
${ }^{2}$ Data transitions prior to DCO $\pm$ edge transition.

## TIMING SPECIFICATIONS

Table 5.

| Parameter | Test Conditions/Comments | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| SYNC TIMING REQUIREMENTS <br> tssync <br> thsync | SYNC to the rising edge of CLK+ setup time SYNC to the rising edge of CLK+ hold time |  | $\begin{aligned} & 0.1 \\ & 0.1 \end{aligned}$ |  | $\begin{aligned} & \text { ns } \\ & \text { ns } \end{aligned}$ |
| SPITIMING REQUIREMENTS |  |  |  |  |  |
| $\mathrm{t}_{\mathrm{DS}}$ | Setup time between the data and the rising edge of SCLK | 2 |  |  | ns |
| $t_{\text {DH }}$ | Hold time between the data and the rising edge of SCLK | 2 |  |  | ns |
| tcık | Period of the SCLK | 40 |  |  | ns |
| ts | Setup time between CSB and SCLK | 2 |  |  | ns |
| $\mathrm{t}_{\mathrm{H}}$ | Hold time between CSB and SCLK | 2 |  |  | ns |
| $\mathrm{tHIGH}^{\text {I }}$ | Minimum period that SCLK is in a logic high state | 10 |  |  | ns |
| tow | Minimum period that SCLK is in a logic low state | 10 |  |  | ns |
| ten_sdo | Time required for the SDIO pin to switch from an input to an output relative to the SCLK falling edge (not shown in Timing Diagrams) | 10 |  |  | ns |
| tils_sDIO | Time required for the SDIO pin to switch from an output to an input relative to the SCLK rising edge (not shown in Timing Diagrams) | 10 |  |  | ns |
| tSPI_RST | Time required after power-up, hard or soft reset until SPI access is available (not shown in Timing Diagrams) | 500 |  |  | $\mu \mathrm{s}$ |

## AD9652

## Timing Diagrams



Figure 2. LVDS Data Output Timing


Figure 3. SYNC Timing Inputs


Figure 4. Serial Port Interface Timing Diagram

## ABSOLUTE MAXIMUM RATINGS

Table 6.

| Parameter | Rating |
| :--- | :--- |
| Electrical | -0.3 V to +3.6 V |
| AVDD3 to AGND | -0.3 V to +2.0 V |
| AVDD_CLK to AGND | -0.3 V to +2.0 V |
| AVDD to AGND | -0.3 V to +2.0 V |
| DRVDD to AGND | -0.3 V to +3.6 V |
| SPIVDD to AGND | 1.2 V to 3.0 V |
| VIN+A/VIN+B, VIN-A/VIN-B to AGND | -0.3 V to AVDD_CLK + |
| CLK+, CLK- to AGND | 0.2 V |
|  | -0.3 V to AVDD_CLK + |
| SYNC to AGND | 0.2 V |
|  | -0.3 V to AVDD +0.2 V |
| VCM to AGND | -0.3 V to SPIVDD +0.3 V |
| CSB to AGND | -0.3 V to SPIVDD +0.3 V |
| SCLK to AGND | -0.3 V to SPIVDD +0.3 V |
| SDIO to AGND | -0.3 V to DRVDD +0.3 V |
| PDWN to AGND | -0.3 V to DRVDD +0.3 V |
| OR+/OR- to AGND | -0.3 V to DRVDD +0.3 V |
| D0 $\pm$ Through D15 $\pm$ to AGND | -0.3 V to DRVDD +0.3 V |
| DCO $\pm$ to AGND |  |
| Environmental | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |
| Operating Temperature Range | $125^{\circ} \mathrm{C}$ |
| (Ambient) |  |
| Maximum Junction Temperature | $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| Under Bias |  |
| Storage Temperature Range |  |
| (Ambient) |  |

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

## THERMAL CHARACTERISTICS

Typical $\theta_{J A}$ is specified for both a 4-layer printed circuit board (PCB) with a solid ground plane from the JEDEC 51-2 and an 8 -layer PCB. The 8 -layer PCB has 2 oz copper layers (M1 and $\mathrm{M} 8), 1 \mathrm{oz}$ copper inner layers, and vias connecting to layers M2, M5, and M7.

As shown in Table 7, airflow increases heat dissipation, which reduces $\theta_{\mathrm{IA}}$. In addition, metal in direct contact with the package leads from metal traces, through holes, ground, and power planes, reduces the $\theta_{\mathrm{JA}}$.

Table 7. Thermal Resistance

|  | Airflow <br> Velocity <br> Package Type | Board Type | $\boldsymbol{\theta}_{\mathbf{J A}}{ }^{2}$ | Unit |
| :---: | :--- | :--- | :--- | :--- |
| 144-Ball CSP_BGA | 0 | 8 -layer PCB | 15.8 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $10 \mathrm{~mm} \times 10 \mathrm{~mm}$ | 1.0 | 8 -layer PCB | 13.9 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $(\mathrm{BC}-144-6)$ | 0 | JEDEC $^{1}$ | 21.7 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
|  | 1.0 | JEDEC $^{1}$ | 19.2 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

${ }^{1}$ Per JEDEC JESD51-7, plus JEDEC 25-5 2S2P test board.
${ }^{2}$ Per JEDEC JESD51-2 (still air) or JEDEC JESD51-6 (moving air).

## ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## AD9652

## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



Figure 5. Pin Configuration
Table 8. Pin Function Descriptions

| Pin No. | Mnemonic | Type | Description |
| :---: | :---: | :---: | :---: |
| ADC Power Supplies |  |  |  |
| K5 | SPIVDD | Supply | Serial Interface Logic Voltage Supply (1.8 V Typical, 3.3 V Optional) |
| K3, K4, K6, K7, K9, K10 | DRVDD | Supply | Digital Output Driver Supply (1.8 V Nominal). |
| $\begin{aligned} & \text { A3, A6, A7, A10, B2, B3, B6, B7, } \\ & \text { B10, B11 } \end{aligned}$ | AVDD3 | Supply | 3.3 V Analog Power Supply (3.3 V Nominal). |
| C6, C7, D6, D7, E6, E7, F6, F7 | AVDD_CLK | Supply | 1.8 V Analog Power Supply for Clock Circuitry (1.8 V Nominal). |
| $\begin{aligned} & \text { C3, C10, D3, D10, E3, E10, F3, } \\ & \text { F10, G3, G6, G7, G10, H3, H6, } \\ & \text { H7, H10 } \end{aligned}$ | AVDD | Supply | 1.8 V Analog Power Supply (1.8 V Nominal). |
| B1, B4, B5, B8, B9, B12, C1, C2, C4, C5, C8, C9, C11, C12, D2, D4, D5, D8, D9, D11, E2, E4, E5, E8, E9, E11, F2, F4, F5, F8, F9, F11, G2, G4, G5, G8, G9, G11, H2, H4, H5, H8, H9, H11 | AGND | Analog Ground | Analog Ground Reference for AVDD3, AVDD_CLK, and AVDD. |
| J3 | DRGND | Digital Ground | Digital and Output Driver Ground Reference. |
| J4 | DRGND | Digital Ground | Digital and Output Driver Ground Reference. |
| J5 | DRGND | Digital Ground | Digital and Output Driver Ground Reference. |


| Pin No. | Mnemonic | Type | Description |
| :---: | :---: | :---: | :---: |
| J6 | DRGND | Digital Ground | Digital and Output Driver Ground Reference. |
| J7 | DRGND | Digital Ground | Digital and Output Driver Ground Reference. |
| J9 | DRGND | Digital Ground | Digital and Output Driver Ground Reference. |
| J10 | DRGND | Digital Ground | Digital and Output Driver Ground Reference. |
| ADC Analog |  |  |  |
| A9 | VIN+A | Input | Differential Analog Input Pin (+) for Channel A. |
| A8 | VIN-A | Input | Differential Analog Input Pin (-) for Channel A. |
| A4 | VIN+B | Input | Differential Analog Input Pin (+) for Channel B. |
| A5 | VIN-B | Input | Differential Analog Input Pin (-) for Channel B. |
| A2 | VCM | Output | Common-Mode Level Bias Output for Analog Inputs. Decouple this pin to ground using a $0.1 \mu \mathrm{~F}$ capacitor. |
| A1 | RBIAS | Output | External Bias Resister Connection. A $10 \mathrm{k} \Omega$ resister must be connected between this pin and analog ground (AGND). |
| A12 | VREF | Input/Output | Voltage Reference Input/Output. |
| A11 | SENSE | Input | Reference Mode Selection (See Table 12). |
| E1 | CLK+ | Input | ADC Clock Input (True). |
| D1 | CLK- | Input | ADC Clock Input (Complement). |
| Digital Inputs |  |  |  |
| F1 | TEST | Input | Pull-Down. Unused digital input, pull to ground through a $50 \Omega$ resistor. |
| G1 | SYNC | Input | Digital Input Clock Synchronization Pin. Tie low if unused. |
| H1 | PDWN | Input | Power-Down Input (Active High). The operation of this pin depends on the SPI mode and can be configured as power-down or standby (see Register 0x08 in Table 17). |
| Digital Outputs |  |  |  |
| J2 | D0+ | Output | Channel A/Channel B LVDS Output Data 0 (True, LSB). |
| J1 | D0- | Output | Channel A/Channel B LVDS Output Data 0 (Complement, LSB). |
| K2 | D1+ | Output | Channel A/Channel B LVDS Output Data 1 (True). |
| K1 | D1- | Output | Channel A/Channel B LVDS Output Data 1 (Complement). |
| L1 | D2+ | Output | Channel A/Channel B LVDS Output Data 2 (True). |
| M1 | D2- | Output | Channel A/Channel B LVDS Output Data 2 (Complement). |
| L2 | D3+ | Output | Channel A/Channel B LVDS Output Data 3 (True). |
| M2 | D3- | Output | Channel A/Channel B LVDS Output Data 3 (Complement). |
| L3 | D4+ | Output | Channel A/Channel B LVDS Output Data 4 (True). |
| M3 | D4- | Output | Channel A/Channel B LVDS Output Data 4 (Complement). |
| L4 | D5+ | Output | Channel A/Channel B LVDS Output Data 5 (True). |
| M4 | D5- | Output | Channel A/Channel B LVDS Output Data 5 (Complement). |
| L5 | D6+ | Output | Channel A/Channel B LVDS Output Data 6 (True). |
| M5 | D6- | Output | Channel A/Channel B LVDS Output Data 6 (Complement). |
| L6 | D7+ | Output | Channel A/Channel B LVDS Output Data 7 (True). |
| M6 | D7- | Output | Channel A/Channel B LVDS Output Data 7 (Complement). |
| L7 | D8+ | Output | Channel A/Channel B LVDS Output Data 8 (True). |
| M7 | D8- | Output | Channel A/Channel B LVDS Output Data 8 (Complement). |
| L8 | D9+ | Output | Channel A/Channel B LVDS Output Data 9 (True). |
| M8 | D9- | Output | Channel A/Channel B LVDS Output Data 9 (Complement). |
| L9 | D10+ | Output | Channel A/Channel B LVDS Output Data 10 (True). |
| M9 | D10- | Output | Channel A/Channel B LVDS Output Data 10 (Complement). |
| L10 | D11+ | Output | Channel A/Channel B LVDS Output Data 11 (True). |
| M10 | D11- | Output | Channel A/Channel B LVDS Output Data 11 (Complement). |
| L11 | D12+ | Output | Channel A/Channel B LVDS Output Data 12 (True). |
| M11 | D12- | Output | Channel A/Channel B LVDS Output Data 12 (Complement). |
| L12 | D13+ | Output | Channel A/Channel B LVDS Output Data 13 (True). |
| M12 | D13- | Output | Channel A/Channel B LVDS Output Data 13 (Complement). |
| K11 | D14+ | Output | Channel A/Channel B LVDS Output Data 14 (True). |


| Pin No. | Mnemonic | Type | Description |
| :---: | :--- | :--- | :--- |
| K12 | D14- | Output | Channel A/Channel B LVDS Output Data 14 (Complement). |
| J11 | D15+ | Output | Channel A/Channel B LVDS Output Data 15 (True, MSB). |
| J12 | D15- | Output | Channel A/Channel B LVDS Output Data 15 (Complement, MSB). |
| G12 | OR+ | Output | Channel A/Channel B LVDS Overrange (True). |
| H12 | OR- | Output | Channel A/Channel B LVDS Overrange (Complement). |
| J8 | DCO+ | Output | Channel A/Channel B LVDS Data Clock Output (True). |
| K8 | DCO- | Output | Channel A/Channel B LVDS Data Clock Output (Complement). |
| SPI Control |  |  |  |
| F12 | SCLK | Input | SPI Serial Clock. |
| E12 | SDIO | Input/Output | SPI Serial Data Input/Output. |
| D12 | CSB | Input | SPI Chip Select (Active Low). This pin must be pulled high at |
| power-up. |  |  |  |

## TYPICAL PERFORMANCE CHARACTERISTICS

AVDD3 $=3.3 \mathrm{~V}, \mathrm{AVDD}=\mathrm{AVDD} \_\mathrm{CLK}=1.8 \mathrm{~V}, \mathrm{SPIVDD}=\mathrm{DRVDD}=1.8 \mathrm{~V}$, sample rate $=310 \mathrm{MSPS}$ (clock input $=1240 \mathrm{MHz}, \mathrm{AD} 9652$ divide by 4), VIN $=-1.0$ dBFS differential, $\mathrm{V}_{\text {REF }}=1.25 \mathrm{~V}$, DCS enabled, dither disabled, unless otherwise noted.


Figure 6. Single Tone Fast Fourier Transform (FFT) with $f_{I_{N}}=70.1 \mathrm{MHz}$ ( $\mathrm{NSD}=-156.7 \mathrm{dBFS} / \mathrm{Hz}$ )


Figure 7. Single Tone FFT with $f_{i N}=70.1 \mathrm{MHz}$ at -7 dBFS $(N S D=-157.6 \mathrm{dBFS} / \mathrm{Hz})$


Figure 8. Single Tone FFT with $f_{i N}=185 \mathrm{MHz}$. at -1 dBFS $($ NSD $=-155.2 \mathrm{dBFS} / \mathrm{Hz})$, Register $0 \times 22 \mathrm{~A}=0 \times 01$


Figure 9. Single Tone FFT with $f_{I N}=70.1 \mathrm{MHz}$ with Dither $(N S D=-156.3 \mathrm{dBFS} / \mathrm{Hz})$


Figure 10. Single Tone FFT with $f_{I N}=70.1 \mathrm{MHz}$ at -7 dBFS with Dither $(N S D=-157.1 \mathrm{dBFS} / \mathrm{Hz})$


Figure 11. Single Tone FFT with $f_{I N}=185 \mathrm{MHz}$ at -1 dBFS with Dither $($ NSD $=-154.9 \mathrm{dBFS} / \mathrm{Hz})$, Register $0 \times 22 \mathrm{~A}=0 \times 01$


Figure 12. Single Tone FFT with $f_{I_{N}}=185 \mathrm{MHz}$ at -7 dBFS (NSD $=-156.9 \mathrm{dBFS} / \mathrm{Hz})$, Register $0 \times 22 \mathrm{~A}=0 \times 01$


Figure 13. $F F T f_{I N}=305 \mathrm{MHz}, A_{I N}=-1 \mathrm{dBFS}$, Dither Off, Register $0 \times 22 A=0 \times 01$


Figure 14. $\mathrm{FFT} f_{I N}=305 \mathrm{MHz}, A_{I N}=-7 \mathrm{dBFS}$, Dither Off,
Register $0 \times 22 A=0 \times 01$


Figure 15. Single Tone FFT with $f_{i N}=185 \mathrm{MHz}$ at -7 dBFS with Dither (NSD $=-156.4 \mathrm{dBFS} / \mathrm{Hz})$, Register $0 \times 22 \mathrm{~A}=0 \times 01$


Figure 16. $F F T f_{I_{N}}=305 \mathrm{MHz}, A_{I N}=-1 \mathrm{dBFS}$, Dither On, Register $0 \times 22 A=0 \times 01$


Figure 17. $F F T f_{I N}=305 \mathrm{MHz}, A_{I N}=-7 \mathrm{dBFS}$, Dither On, Register $0 \times 22 A=0 \times 01$


Figure 18. FFT $f_{I N}=400 \mathrm{MHz}, A_{I N}=-1 \mathrm{dBFS}$, Dither Off, Register $0 \times 22 \mathrm{~A}=0 \times 02$


Figure 19. FFT $f_{I_{N}}=400 \mathrm{MHz}, A_{I N}=-7 \mathrm{dBFS}$, Dither Off, Register $0 \times 22 A=0 \times 02$


Figure 20. Single Tone SNR/SFDR vs. Input Amplitude ( $A_{I N}$ ) with $f_{I N}=90.1 \mathrm{MHz}, V_{R E F}=1.25 \mathrm{~V}$, Over Temperature, Dither Off


Figure 21. FFT $f_{I N}=400 \mathrm{MHz}, A_{I N}=-1 \mathrm{dBFS}$, Dither On, Register $0 \times 22 A=0 \times 02$


Figure 22. FFT $f_{I_{N}}=400 \mathrm{MHz}, A_{I N}=-7 \mathrm{dBFS}$, Dither On, Register $0 \times 22 A=0 \times 02$


Figure 23. Single Tone SNR/SFDR vs. Input Amplitude (AIN) with $f_{I N}=90.1 \mathrm{MHz}, V_{\text {REF }}=1.25$ V, Over Temperature, Dither On


Figure 24. Single Tone SNR/SFDR vs. Input Amplitude (AIN) with $f_{I N}=90.1 \mathrm{MHz}, V_{\text {REF }}=1.0 \mathrm{~V}$, Over Temperature, Dither Off


Figure 25. Single Tone SNR/SFDR vs. Input Frequency $\left(f_{I N}\right)$,
Amplitude $=-1 \mathrm{dBFS}, V_{\text {REF }}=1.25 \mathrm{~V}$


Figure 26. Single Tone SNR/SFDR vs. Input Frequency ( $f_{I N}$ ),
Amplitude $=-7 \mathrm{dBFS}, V_{\text {REF }}=1.25 \mathrm{~V}$


Figure 27. Single Tone SNR/SFDR vs. Input Amplitude (AIN) with $f_{I_{N}}=$ 90.1 MHz, VREF = 1.0 V, Over Temperature, Dither On


Figure 28. Single Tone SNR/SFDR vs. Input Frequency ( $f_{I N}$ ),
Amplitude $=-1 \mathrm{dBFS}, V_{\text {REF }}=1.0 \mathrm{~V}$


Figure 29. Single Tone SNR/SFDR vs. Input Frequency ( $f_{I N}$ ), Amplitude $=-7 \mathrm{dBFS}, V_{\text {REF }}=1.0 \mathrm{~V}$


Figure 30. Two Tone SFDR/Intermodulation Distortion (IMD) vs. Input Amplitude, for $f_{I N}=70.1 \mathrm{MHz}$ and 72.1 MHz , Dither Disabled


Figure 31. Two Tone SFDR/IMD vs. Input Amplitude, for $f_{I N}=184 \mathrm{MHz}$ and 187 MHz, Dither Disabled, Register 0x22A = 0x01


Figure 32. Two Tone FFT with $f_{i N}=89.1 \mathrm{MHz}$ and $92.1 \mathrm{MHz}, V R E F=1.25 \mathrm{~V}$


Figure 33. Two Tone SFDR/IMD vs. Input Amplitude, for $f_{i N}=70.1 \mathrm{MHz}$ and 72.1 MHz, Dither Enabled


Figure 34. Two Tone SFDR/IMD vs. Input Amplitude, for $f_{I N}=184 \mathrm{MHz}$ and 187 MHz, Dither Enabled, Register 0x22A = 0x01


Figure 35. Grounded Input Histogram


Figure 36. Encode Rate Sweep, $f_{I N}=90.1 \mathrm{MHz}$ at -7 dBFS ,
$V_{\text {REF }}=1.25 \mathrm{~V}$ and 1.0 V


Figure 37. DNL with Dither Off, $f_{I N}=30 \mathrm{MHz}$


Figure 38. DNL with Dither On, $f_{i N}=30 \mathrm{MHz}$


Figure 39. Encode Rate Sweep, $f_{i N}=90.1 \mathrm{MHz}$ at -1 dBFS , $V_{\text {REF }}=1.25 \mathrm{~V}$ and 1.0 V


Figure 40. INL with Dither Off, $f_{I N}=30 \mathrm{MHz}$


Figure 41. INL with Dither On, $f_{I N}=30 \mathrm{MHz}$

## Data Sheet

## EQUIVALENT CIRCUITS



Figure 42. Equivalent Analog Input Circuit


Figure 43. Equivalent Clock Circuit


Figure 44. Equivalent LVDS Output Circuit (DCO $\pm, O R \pm$, and D0 $\pm$ to $D 15 \pm$ )


Figure 45. Equivalent SDIO Circuit


Figure 46. Equivalent PDWN Input Circuit


Figure 47. Equivalent SCLK Input Circuit


Figure 48. Equivalent CSB Input Circuit


Figure 49. Equivalent SYNC Input Circuit


Figure 50. Equivalent SENSE Circuit


Figure 51. Equivalent VREF Circuit

## THEORY OF OPERATION

The AD9652 is a dual, 16 -bit ADC with sampling speeds of up to 310 MSPS. The AD9652 is designed to support communications and instrumentation applications where high performance and wide bandwidth are desired.
The dual ADC design can be used for diversity receivers, where the ADCs operate identically on the same carrier but from two separate antennae. The ADCs can also be operated with independent analog inputs. The user can sample frequencies from dc to 310 MHz using appropriate low-pass or band-pass filtering at the ADC inputs with little loss in ADC performance. A typical operation of 485 MHz at the analog input is permitted but occurs at the expense of increased ADC noise and distortion.
Synchronization capability is provided to allow synchronized timing between multiple devices.
Programming and control of the AD9652 are accomplished using a 3-wire, SPI-compatible serial interface.

## ADC ARCHITECTURE

The AD9652 consists of a dual, buffered front-end sample-andhold circuit, followed by a pipelined switched-capacitor ADC. The AD9652 uses a unique architecture that utilizes the benefits of pipelined converters, as well as a novel input circuit to maximize performance of the first stage.

The quantized outputs from each stage are combined to produce a 16-bit result in the digital correction logic. The pipelined architecture permits the first stage to operate on a new input sample, and the remaining stages to operate on the preceding samples. Sampling occurs on the rising edge of the clock.
Each stage of the pipeline, excluding the last, consists of a low resolution flash ADC connected to a switched-capacitor digital-to-analog converter (DAC) and an interstage residual multiplying DAC (MDAC). The MDAC magnifies the difference between the reconstructed DAC output and the flash input for the next stage in the pipeline. One bit of redundancy is used in each stage to facilitate digital correction of flash errors. The last stage consists of a flash ADC.
The AD9652 uses internal digital processing to continually track internal errors that occur at each of the pipeline stages and corrects for them to ensure continuous performance over various operating conditions. This requires additional start-up time due to the resetting and collection of correction data.
The input stage of each channel contains a differential sampling circuit that can be ac-coupled or dc-coupled in differential or single-ended modes. The output staging block aligns the data, corrects errors, and passes the data to the output buffers. The output buffers are powered from a separate supply, allowing digital output noise to be separated from the analog core. During power-down, the output buffers enter a high impedance state.

## ANALOG INPUT CONSIDERATIONS

The analog inputs to the AD9652 are high performance differential buffers that are designed for optimum performance while processing a differential input signal. The input buffer provides a consistent input impedance to ease interface of the analog input.
The differential analog input impedance is approximately $54 \mathrm{k} \Omega$ in parallel with a 5.8 pF capacitor. A passive network of discrete components can create a low-pass filter at the ADC input; the precise values are dependent on the application.
In intermediate frequency (IF) undersampling applications, reduce the shunt capacitors. In combination with the driving source impedance, the shunt capacitors limit the input bandwidth. Refer to the Analog Dialogue article, "Transformer-Coupled Front-End for Wideband A/D Converters," for more information on this subject.
The AD9652 uses internal optimized settings for the various input signal frequencies. Register 0x22A configures the ADC for the desired frequency band.

Table 9. Register 0x22A Settings

| Register 0x22A Setting | Input Frequency Range |
| :--- | :--- |
| 0 (Default) | 0 to 155 MHz ( st $^{\text {st }}$ Nyquist) |
| 1 | 155 to $310 \mathrm{MHz}\left(2^{\text {nd }}\right.$ Nyquist) |
| 2 | 310 MHz and above (3rd Nyquist) |

For best dynamic performance, the source impedances driving each of the differential inputs, match VIN $\pm \mathrm{x}$, and differentially balance the inputs.

## Input Common Mode

The analog inputs of the AD9652 are not internally dc biased. In ac-coupled applications, the user must provide this bias externally. Setting the device so that the common-mode voltage equals 2.0 V is recommended for optimum performance. An on-board common-mode voltage reference is included in the design and is available from the VCM pin. Using the VCM output to set the input common mode is recommended. The VCM pin must be decoupled to ground with a $0.1 \mu \mathrm{~F}$ capacitor, as described in the Applications Information section. Place this decoupling capacitor close to the pin to minimize the series resistance and inductance between the device and this capacitor.

## Common-Mode Voltage Servo

In applications where there may be a voltage loss between the VCM output of the AD9652 and the analog inputs, the common-mode voltage servo can be enabled. When the inputs are ac-coupled and a resistance of $>100 \Omega$ is placed between the VCM output and the analog inputs, a significant voltage drop can occur; enable the common-mode voltage servo. Setting Bit 0 in Register 0x0F to a logic high enables the VCM servo mode.

In this mode, the AD9652 monitors the common-mode input level at the analog inputs and adjusts the VCM output level to keep the common-mode input voltage at an optimal level. If both channels are operational, Channel A is monitored. However, if Channel A is in power-down or standby mode, then Channel B input is monitored.

## Dither

The AD9652 has an optional internal dither circuitry that can improve SFDR, particularly for small signals. Dithering is the act of injecting a known but random amount of white noise into the input of the AD9652. Dithering has the effect of improving the local linearity within the ADC transfer function. The AD9652 allows dither to be added to either ADC input independently. The full scale of the dither DAC is small enough that enabling dither does not limit the external input signal amplitude.
As shown in Figure 52, the dither that is added to the input of the ADC through the dither DAC is precisely subtracted out digitally to minimize SNR degradation. When dithering is enabled, the dither DAC is driven by a pseudorandom number generator (PN gen). In the AD9652, the dither DAC is precisely calibrated to result in only a very small degradation in SNR and SINAD when dither is enabled.


Figure 52. Dither Block Diagram
The SFDR improvement comes at the expense of SNR degradation, but because the dither is internal and can be correlated, the impact on SNR is typically limited to less than 0.5 dB in the first Nyquist zone. Enabling internal dither does not impact full-scale dynamic range. The magnitude of dither is controllable, which allows the user to select the desired trade-off between SFDR improvement vs. SNR degradation.
To enable dither, set Bit 4 of Register 0x30. To modify the dither gain, use Register 0x212[7:4].

Table 10. Dither Gain

| Register 0x212[7:4] Setting | Gain Ratio | Gain (\%) |
| :--- | :--- | :--- |
| Ob0000 (default) | Maximum dither | 100 |
| Ob0001 | $255 / 256 \times \max$ | 99.6 |
| Ob0010 | $254 / 256 \times \max$ | 99.2 |
| Ob0011 | $252 / 256 \times \max$ | 98.4 |
| Ob0100 | $248 / 256 \times \max$ | 96.8 |
| Ob0101 | $240 / 256 \times \max$ | 93.75 |
| Ob0110 | $224 / 256 \times \max$ | 87.5 |
| Ob0111 | $192 / 256 \times \max$ | 75 |
| Ob1000 | Minimum dither | 50 |

## Large Signal Fast Fourier Transform

In most cases, dithering does not improve SFDR for large signal inputs close to full scale, for example, with a -1 dBFS input. For large signal inputs, the SFDR is typically limited by front-end sampling distortion, which dithering cannot improve. However, even for such large signal inputs, dithering can be useful for certain applications because it makes the noise floor whiter. As is common in pipeline ADCs, the AD9652 contains small DNL errors caused by random component mismatches that produce spurs or tones that make the noise floor somewhat randomly colored device-to-device. Although these tones are typically at very low levels and do not limit SFDR when the ADC is quantizing large signal inputs, dithering converts these tones to noise and produces a whiter noise floor.

## Small Signal FFT

For small signal inputs, the front-end sampling circuit typically contributes very little distortion, and the SFDR is likely to be limited by tones caused by DNL errors due to random component mismatches. Therefore, for small signal inputs (typically, those below -6 dBFS ), dithering can significantly improve SFDR by converting these DNL tones to white noise.

## Static Linearity

Dithering also removes sharp local discontinuities in the INL transfer function of the ADC and reduces the overall peak-topeak INL.
Utilizing dither randomizes local small signal DNL errors that produce the discontinuities in the INL transfer function and therefore improve the peak-to-peak INL performance.

## Differential Input Configurations

Optimum performance is achieved by driving the AD9652 in a differential input configuration. For baseband applications, the ADL5566, AD8138, ADA4937-2, ADA4938-2, and ADA4930-2 differential drivers provide excellent performance and a flexible interface to the ADC.

The output common-mode voltage of the ADA4930-2 is easily set with the VCM pin of the AD9652 (see Figure 53), and the driver can be configured in a Sallen-Key filter topology to provide band limiting of the input signal.


Figure 53. Differential Input Configuration Using the ADA4930-2

## AD9652

For baseband applications where SNR is a key parameter, differential transformer coupling is the recommended input configuration. An example is shown in Figure 54. To bias the analog input, the VCM voltage can be connected to the center tap of the secondary winding of the transformer.


Figure 54. Differential Transformer-Coupled Configuration
The signal characteristics must be considered when selecting a transformer. Most RF transformers saturate at frequencies below a few megahertz. Excessive signal power can also cause core saturation, which leads to distortion.
At input frequencies in the second Nyquist zone and above, the noise performance of most amplifiers is not adequate to achieve the true SNR performance of the AD9652. For applications where SNR is a key parameter, differential double balun coupling is the recommended input configuration (see Figure 56). In this configuration, the input is ac-coupled and the VCM voltage is provided to each input through a $33 \Omega$ resistor. These resistors compensate for losses in the input baluns to provide a $50 \Omega$ impedance to the driver.
In the double balun and transformer configurations, the value of the input capacitors and resistors is dependent on the input frequency and source impedance. Based on these parameters, the value of the input resistors and capacitors may need to be adjusted, or some components may need to be removed. Table 11 displays recommended values to set the RC network for different
input frequency ranges. However, these values are dependent on the input signal; use the bandwidth only as a starting guide. Note that the values given in Table 11 are for each R1, R2, C1, C2, and R3 component shown in Figure 54 and Figure 56.

Table 11. Example RC Network

| Frequency <br> Range <br> (MHz) | R1 <br> Series <br> $\mathbf{( \Omega )}$ | C1 <br> Differential <br> (pF) | R2 <br> Series <br> $\mathbf{( \Omega )}$ | C2 <br> Shunt <br> (pF) | R3 <br> Shunt <br> $(\mathbf{\Omega})$ |
| :--- | :--- | :--- | :--- | :--- | :--- |
| 0 to 100 | 33 | Open | 0 | 15 | 49.9 |
| 100 to 300 | 15 | Open | 15 | 2.7 | 0 |

An alternative to using a transformer-coupled input at frequencies in the second Nyquist zone is to use an amplifier with variable gain. The AD8375 or AD8376 digital variable gain amplifier (DVGA) provides good performance for driving the AD9652. Figure 55 shows an example of the AD8376 driving the AD9652 through a band-pass antialiasing filter.


1. ALL INDUCTORS ARE COILCRAFT ${ }^{\circledR}$ 0603CS COMPONENTS WITH THE EXCEPTION OF THE $1 \mu \mathrm{H}$ CHOKE INDUCTORS (COIL CRAFT 0603LS).
2. FILTER VALUES SHOWN ARE FOR A 20MHz BANDWIDTH FILTER CENTERED AT 140 MHz

Figure 55. Differential Input Configuration Using the AD8376

| Table 12. V ReF Configuration Options |
| :--- |
| Selected Mode |
| External Reference |
| Internal Fixed Reference |
| Inter Voltage |
| AVDD |
| GND |

[^2]
## VOLTAGE REFERENCE

A stable and accurate voltage reference is built into the AD9652. The full-scale input range can be adjusted by varying the reference voltage via the SPI. The input span of the ADC linearly tracks reference voltage changes.

## Internal Reference Connection

A stable and accurate programmable reference is built into the AD9652, allowing a voltage reference from 1.0 V to 1.25 V to provide up to a 2.5 V p-p differential full-scale input. By default the $\mathrm{V}_{\text {ref }}$ voltage is set 1.25 V , but can be modified using Register 0x18[2:0], Vref select.

To configure the AD9652 for an internal reference, the SENSE pin must be tied low. When SENSE is tied low, the ADC uses $\mathrm{V}_{\text {REF }}$ directly and provides a differential input voltage of two times the $\mathrm{V}_{\text {Ref }}$ value.

To achieve optimal noise performance when using the internal reference, it is recommended that the VREF pin be decoupled by $1.0 \mu \mathrm{~F}$ and $0.1 \mu \mathrm{~F}$ capacitors close to the pin. Figure 57 shows the configuration for the internal reference connection resulting in a input voltage set by VREF, that is, a 2.5 V p-p differential full-scale input.


Figure 57. Internal Reference Configuration
If the internal reference of the AD9652 drives multiple converters to improve gain matching, the loading of the reference by the other converters must be considered. Figure 58 shows how the internal reference voltage is affected by loading.


Figure 58. Reference Voltage Error vs. Load Current

## External Reference Operation

The use of an external reference can be necessary to enhance the gain accuracy of the ADC or improve thermal drift characteristics.
When the SENSE pin is tied to AVDD, the internal reference is disabled, allowing the use of an external reference that is applied to the VREF pin. An internal reference buffer loads the external reference with an equivalent $6 \mathrm{k} \Omega$ load. The internal buffer generates the positive and negative full-scale references for the ADC core. Therefore, the external reference must be limited to a maximum of 1.25 V to maintain an input voltage of 2.5 V p-p differential full-scale input or less.

## CLOCK INPUT CONSIDERATIONS

For optimum performance, clock the AD9652 sample clock inputs, CLK+ and CLK-, with a differential signal with a high slew rate. The signal is typically ac-coupled into the CLK+ and CLK- pins via a transformer or via capacitors. These pins are biased internally (see Figure 59) and require no external bias. If the inputs are floated, the CLK- pin is intentionally biased slightly lower than CLK+ to prevent spurious clocking (this is not shown in Figure 59).


Figure 59. Simplified Equivalent Clock Input Circuit

## Clock Input Options

The AD9652 has a very flexible clock input structure. The clock input can be a CMOS, LVDS, LVPECL, or sine wave signal. Regardless of the type of signal being used, clock source jitter is of the most concern, as described in the Jitter Considerations section.
Figure 60 and Figure 61 show two preferable methods for clocking the AD9652 (at clock rates of up to 1240 MHz ). A low jitter clock source is converted from a single-ended signal to a differential signal using an RF balun or RF transformer.

The RF balun configuration is recommended for clock frequencies between 125 MHz and 1240 MHz , and the RF transformer is recommended for clock frequencies from 80 MHz to 200 MHz . The back-to-back Schottky diodes are used across the transformer secondary or the balun balanced side to limit clock amplitude excursions into the AD9652 to approximately 0.8 V p-p differential. This limit helps prevent large voltage swings of the clock from feeding through to other portions of the AD9652, while preserving fast rise and fall times of the clock, which are critical to low jitter performance.


Figure 60. Transformer-Coupled Differential Clock (Up to 200 MHz)


Figure 61. Balun-Coupled Differential Clock (Up to 1240 MHz)
If a low jitter clock source is not available, another option is to ac couple a differential PECL signal to the sample clock input pins as shown in Figure 62. The AD9510, AD9511, AD9512, AD9513, AD9514, AD9515, AD9516-5, AD9517-1, AD9518-1, AD9520-5, AD9522-1, AD9523, AD9524, and ADCLK905/ ADCLK907/ADCLK925 clock drivers offer excellent jitter performance.


A third option is to ac couple a differential LVDS signal to the sample clock input pins, as shown in Figure 63. The AD9510, AD9511, AD9512, AD9513, AD9514, AD9515, AD9516-5, AD9517-1, AD9518-1, AD9520-5, AD9522-1, AD9523, and AD9524 clock drivers offer excellent jitter performance.


Figure 63. Differential LVDS Sample Clock (Up to 625 MHz )

## Input Clock Divider

The AD9652 contains an input clock divider with the ability to divide the input clock by integer values of $1,2,4$ or 8 . In these cases, the DCS is enabled by default on power-up. The clock divide ratio is set in Register 0x0B.
The AD9652 clock divider can be synchronized using the external SYNC input. Bit 1 and Bit 2 of Register 0x100 allow the clock divider to be resynchronized on every SYNC signal or only on the first SYNC signal after the register is written. A valid SYNC causes the clock divider to reset to its initial state. This synchronization feature allows multiple devices to have their clock dividers aligned to guarantee simultaneous input sampling. With the divider enabled and the SYNC option used, the ADC clock divider output phase can be adjusted after synchronization in increments of input clock cycles using Register 0x16.

Drive the SYNC input using a single-ended CMOS type signal. If not used, connect the SYNC pin to ground.

## Clock Duty Cycle

Typical high speed ADCs use both clock edges to generate a variety of internal timing signals and, as a result, may be sensitive to clock duty cycle. Commonly, $\mathrm{a} \pm 5 \%$ tolerance is required on the clock duty cycle to maintain dynamic performance characteristics.
The AD9652 contains a clock DCS that retimes the nonsampling (falling) edge, providing an internal clock signal with a nominal $50 \%$ duty cycle. This allows the user to provide a wide range of clock input duty cycles without affecting the performance of the AD9652.

Jitter on the rising edge of the input clock is still of paramount concern and is not reduced by the duty cycle stabilizer. The DCS control loop does not function for clock rates less than 80 MHz nominally. The loop has a time constant associated with it that must be considered when the clock rate changes dynamically. A wait time of $1.5 \mu \mathrm{~s}$ to $5 \mu \mathrm{~s}$ is required after a dynamic clock frequency increase or decrease before the DCS loop is relocked to the input clock. During that time period, the loop is not locked, the DCS loop is bypassed, and internal device timing is dependent on the duty cycle of the input clock signal. In some cases, it may be appropriate to disable the duty
cycle stabilizer, for example, if a high quality RF clock is available to drive the AD9652 clock input and does not need adjustment in duty cycle correction. In most other applications, enabling the DCS circuit is recommended to maximize ac performance.

## Jitter Considerations

High speed, high resolution ADCs are sensitive to the quality of the clock input. The degradation in SNR at a given input frequency ( $\mathrm{fin}^{\mathrm{N}}$ ) due to jitter ( $\mathrm{t}_{\mathrm{J}}$ ) can be calculated by

$$
S N R_{H F}=-10 \log \left[\left(2 \pi \times f_{I N} \times t_{J R M S}\right)^{2}+10^{\left(-S N R_{L F} / 10\right)}\right]
$$

In the equation, the rms aperture jitter represents the root-mean-square of all jitter sources, which includes the clock input, the analog input signal, and the ADC aperture jitter specification. IF undersampling applications are particularly sensitive to jitter, as shown in Figure 64.


Figure 64. SNRFS vs. Input Frequency and Jitter
Treat the clock input as an analog signal in cases where aperture jitter may affect the dynamic range of the AD9652.
Drive external clock sources and buffers from a clean ADC output driver supply to avoid modulating the ADC clock with noise. Low jitter, crystal controlled oscillators make the best clock sources. If the clock is generated from another type of source (by gating, dividing, or another method), retime it by the original clock at the last step.
Refer to the AN-501 Application Note, Aperture Uncertainty and ADC System Performance, and the AN-756 Application Note, Sampled Systems and the Effects of Clock Phase Noise and Jitter, for more information about jitter performance as it relates to ADCs.

## POWER DISSIPATION AND STANDBY MODE

As shown in Figure 65, the power dissipated by the AD9652 is proportional to its sample rate. The data in Figure 65 was taken using the same operating conditions as those used for the Typical Performance Characteristics section.


Figure 65. Power and Current vs. Sample Rate
By asserting power-down (either through setting Register 0x08 or by asserting the PDWN pin high), the AD9652 is placed in power-down mode. In this state, the ADC typically dissipates less than 1 mW . During power-down, the output drivers are placed in a high impedance state. Deasserting the PDWN pin (forcing it low) returns the AD9652 to its normal operating mode. Note that the level on PDWN is referenced to the digital output driver supply (DRVDD) and cannot exceed that supply voltage.
Low power dissipation in power-down mode is achieved by shutting down the reference, reference buffer, biasing networks, and clock. Internal capacitors are discharged when entering power-down mode and then must be recharged when returning to normal operation. As a result, wake-up time is related to the time spent in power-down mode, and shorter power-down cycles result in proportionally shorter wake-up times.
When using the SPI port interface, the user can place the ADC in power-down mode or standby mode. Standby mode allows the user to keep the internal reference circuitry powered when faster wake-up times are required. See the AN-877 Application Note, Interfacing to High Speed ADCs via SPI, for additional details.

## INTERNAL BACKGROUND CALIBRATION

The AD9652 uses a background calibration to continually correct errors between internal analog circuits to maintain the high level of noise performance over varying conditions. The calibration correction digitally monitors the errors in the various analog blocks, calculates the error, and applies corrections. The background correction is calculated every $3 \times 2^{33}$ samples; therefore, when running at 310 MSPS, the update rate is about 83 seconds. Each calibration cycle is independent from previous calibrations to improve tracking. There are no requirements on the input signal for the background calibration.
The calibration occurs independently for each ADC path. The background calibration continually operates but does not update if the input signal is significantly out of range (beyond the OTR) because this can cause errors in the calibration calculation.

The calibration engine monitors any errors and resets the calibration cycle if the input signal exceeds the input range for 1000 samples within a single calibration cycle.
At startup, when the AD9652 is first powered and a valid clock is applied, a fast start-up background calibration is performed and converges 64 times faster than the normal calibration cycle. At 310 MSPS, the fast start-up calibration updates after 1.3 seconds. The fast start-up calibration allows the AD9652 to be used sooner than waiting for a full calibration cycle and typically degrades SNR performance by less than 0.5 dB . This degradation lasts until a full calibration cycle completes.
In cases where configuration of the AD9652 changes and a recalibration is needed, a fast start-up calibration can be initiated by an SPI register write or by asserting and deasserting the PDWN pin.

To initiate using the SPI register, use Register 0x08[1:0]. To start a new fast calibration, put either or both ADC channels in standby and then return them to normal operation mode by writing $0 \times 2$ and then $0 \times 0$ to Register 0x08[1:0]. After returning to normal operation mode, the fast calibration is initiated one time followed by the normal, full calibration cycle. In addition to standby, this is also the case for power-down. Writing a $0 \times 1$ followed by a $0 x 0$ initiates a fast calibration. Alternatively, a fast start-up calibration can be initiated by writing $0 \times 0 \mathrm{C}$ and then 0x08 to Register 0x4FB.

The PDWN pin can be configured to put the device in powerdown or standby mode based on the setting in Register 0x08[1:0]. Transitioning from either power-down or standby into normal mode causes a fast calibration to be initiated. Configuration changes that require a new calibration include, but are not limited to, changes of setting for VREF, dither enable/disable, clock input changes, and DCS state changes.
There are various advanced configuration options associated with the background calibration for applications that require special treatment. The options include an optional recovery mode for standby and a pausing background calibration.
If standby is used in an application, by default, the AD9652 keeps the current corrections, but initiates a new fast calibration when returning to normal operation mode. For standby, if conditions have not significantly changed, the AD9652 can be configured to retain the last correction coefficients by writing $0 \times 00$ to Register 0x4FA before entering the standby mode. This returns the device to the same operation as when it entered standby, retaining previous calibration values in standby mode and continuing the normal calibration cycle when returned to normal operation mode.

Although this is not recommended, in some instances such as when all the environmental, clocking, and input signals are very stable, the calibration can be paused. Pausing the background calibration causes a slight degradation in performance, but can be accomplished by writing $0 \times 1$ to Register $0 \times 4 \mathrm{FB}$, Bit 0 . To reenable the background calibration, write $0 \times 0$ to Register 0x4FB, Bit 0 . Note: Register $0 \times 4$ FB has reserved bits that must be preserved when accessing that and similar registers.

## DIGITAL OUTPUTS

The AD9652 output drivers are for standard ANSI LVDS, but optionally the drive current can be reduced using Register 0x15. The reduced drive current for the LVDS outputs potentially reduce the digitally induced noise.
As detailed in the AN-877 Application Note, Interfacing to High Speed ADCs via SPI, the data format can be selected for offset binary, twos complement, or gray code when using the SPI control.
The AD9652 has a flexible three-state ability for the digital output pins. The three-state mode is enabled when the device is set for power-down mode.

## Timing

The AD9652 provides latched data with a pipeline delay of 26 input sample clock cycles. Data outputs are available one propagation delay ( $\mathrm{t}_{\mathrm{PD}}$ ) after the rising edge of the clock signal.

Minimize the length of the output data lines and the corresponding loads to reduce transients within the AD9652. These transients can degrade converter dynamic performance.
The lowest typical conversion rate of the AD9652 is 80 MSPS. At clock rates below 80 MSPS, dynamic performance may degrade.

## Data Clock Output

The AD9652 also provides a data clock output (DCO) intended for capturing the data in an external register. Figure 2 shows a timing diagram of the AD9652 output modes. The DCO relative to the data output can be adjusted using Register 0x17. There are 32 delay settings with approximately 81 ps per step. Data is output in a DDR format and is aligned to the rising and falling edges of the clock derived from $\mathrm{DCO} \pm$.

## ADC OVERRANGE

The ADC overrange (OR) indicator is asserted when an overrange is detected on the input of the ADC. The overrange condition is determined at the output of the ADC pipeline and, therefore, is subject to a latency of 26 ADC clocks. An overrange at the input is indicated by this bit, 26 clock cycles after it occurs.

Table 13. Output Data Format

| Differential Input Voltage (V): <br> (VIN+x) - (VIN-x) <br> Input Span = 2.5 V p-p (V) | Offset Binary Output Mode | Twos Complement Mode (Default) | OR $\pm$ Pin Logic Level |
| :--- | :--- | :--- | :--- |
| $<-1.25$ | 00000000000000 | 10000000000000 | 1 |
| -1.25 | 00000000000000 | 10000000000000 | 0 |
| 0 | 10000000000000 | 00000000000000 | 0 |
| +1.25 | 11111111111111 | 01111111111111 | 0 |
| $>+1.25$ | 11111111111111 | 01111111111111 | 1 |

## FAST THRESHOLD DETECTION (FDA/FDB)

In receiver applications, it is desirable to have a mechanism to reliably determine when the converter is about to be clipped. The standard overflow indicator on the OR $\pm$ pins provide delayed information, which is synchronized with the output data. The delayed indicator is of limited value in preventing clipping in this case. Therefore, it is helpful to have a programmable threshold below full scale that allows time to reduce external gain before the clip occurs. In addition, because input signals can have significant slew rates, latency of this function is of concern.
Using the SPI port, the user can provide a threshold above which the fast detect (FD) output is active. Bit 0 of Register $0 \times 45$ enables the FD feature. Register 0x47 to Register 0x4C allow the user to set the threshold levels and timing. As long as the signal is below the selected threshold, the FD output remains low. In this mode, the magnitude of the data is considered in the calculation of the condition, but the sign of the data (either positive or negative) is not considered. The threshold detection responds identically to positive and negative signals outside the desired range (magnitude).
The fast detect indicators, FDA for Channel A and FDB for Channel B, are asserted when the input magnitude exceeds the value programmed in the fast detect upper threshold register, Register 0x47.

The selected threshold register is compared with the signal magnitude at the output of the ADC. The fast upper threshold detection has a latency of seven clock cycles. The approximate upper threshold is a 4-bit value defined by

Upper Threshold $(\%$ Full Scale $)=$ $(($ Register $0 \times 47$ value $) / 8) \times 100 \%$
The FD indicators are not cleared until the signal drops below the lower threshold for the programmed dwell time. The lower threshold is programmed in the fast detect lower threshold registers, Register 0x49 and Register 0x4A. The fast detect lower threshold register is a 15 -bit register that is compared with the signal magnitude at the output of the ADC. This comparison is subject to the ADC pipeline latency but is accurate in terms of converter resolution. The lower threshold is defined by

$$
\begin{aligned}
& \text { Lower Threshold }(\% \text { Full Scale })= \\
& ((\text { Register } 0 x 49 / \text { Register } 0 x 4 A \text { value }) / 32767) \times 100 \%
\end{aligned}
$$

For example, to set an upper threshold of $50 \%$ full scale, write $0 \times 04$ to Register 0x47, and to set a lower threshold of $40 \%$ full scale, write 0x3333 to Register 0x49 and Register 0x4A.

The dwell time can be programmed from 1 sample clock cycle to 65,535 sample clock cycles by placing the desired value in the fast detect dwell time registers, Register 0x4B and Register 0x4C (see Figure 66).


## SERIAL PORT INTERFACE

The AD9652 serial port interface (SPI) allows the user to configure the converter for specific functions or operations through a structured register space provided inside the ADC. The SPI gives the user added flexibility and customization, depending on the application. Addresses are accessed via the serial port and can be written to or read from via the port. Memory is organized into bytes that can be further divided into fields. These fields are documented in the Memory Map section. For detailed operational information, see the AN-877 Application Note, Interfacing to High Speed ADCs via SPI.

## CONFIGURATION USING THE SPI

Three pins define the SPI of this ADC: the SCLK pin, the SDIO pin, and the CSB pin (see Table 14). The SCLK (serial clock) pin synchronizes the read and write data presented from/to the ADC. The SDIO (serial data input/output) pin is a dual-purpose pin that allows data to be sent and read from the internal ADC memory map registers. The CSB (chip select bar) pin is an active low control that enables or disables the read and write cycles.

Table 14. Serial Port Interface Pins

| Pin | Function |
| :--- | :--- |
| SCLK | Serial clock. The serial shift clock input, which synchronizes <br> serial interface reads and writes. |
| SDIO | Serial data input/output. A dual-purpose pin that <br> typically serves as an input or an output, depending on <br> the instruction being sent and the relative position in the <br> timing frame. <br> CSB |
| Chip select bar. An active low control that gates the read <br> and write cycles. Must be pulled to logic high during <br> power up. |  |

The falling edge of CSB, in conjunction with the rising edge of SCLK, determines the start of the framing. An example of the serial timing and its definitions can be found in Table 5 and Figure 4.
Other modes involving the CSB pin are available. The CSB pin can be held low indefinitely, which permanently enables the device; this is called streaming. The CSB pin can stall high between bytes to allow for additional external timing. When CSB is tied high, SPI functions are placed in a high impedance mode.

During an instruction phase, a 16-bit instruction is transmitted. Data follows the instruction phase, and its length is determined by the W0 and the W1 bits.
All data is composed of 8 -bit words. The first bit of each individual byte of serial data indicates whether a read or write command is issued. This allows the serial data input/output (SDIO) pin to change direction from an input to an output.

In addition to word length, the instruction phase determines whether the serial frame is a read or write operation, allowing the serial port to be used both to program the chip and to read the contents of the on-chip memory. If the instruction is a readback operation, performing a readback causes the serial data input/ output (SDIO/DCS) pin to change direction from an input to an output at the appropriate point in the serial frame.
Data can be sent in MSB first mode or in LSB first mode. MSB first is the default on power-up and can be changed via the SPI port configuration register. For more information about this and other features, see the AN-877 Application Note.

## HARDWARE INTERFACE

The pins described in Table 14 comprise the physical interface between the user programming device and the serial port of the AD9652. The SCLK pin and the CSB pin function as inputs when using the SPI interface. The SDIO pin is bidirectional, functioning as an input during write phases and as an output during readback.
The SPI interface is flexible enough to be controlled by either field-programmable grid arrays (FPGAs) or microcontrollers. One method for SPI configuration is described in detail in the AN-812 Application Note, Microcontroller-Based Serial Port Interface (SPI) Boot Circuit.
The SPI port must not be active during periods when the full dynamic performance of the converter is required. Because the SCLK signal, the CSB signal, and the SDIO signal are typically asynchronous to the ADC clock, noise from these signals can degrade converter performance. If the on-board SPI bus is used for other devices, it may be necessary to provide buffers between this bus and the AD9652 to prevent these signals from transitioning at the converter inputs during critical sampling periods.

## CONFIGURATION WITHOUT THE SPI

In applications that do not interface to the SPI control registers, the SDIO pin and the SCLK pin serve as standalone CMOScompatible control pins. When the device is powered up, it is assumed that the user intends to use the pins as static control lines for the DCS and output data format feature control. In this mode, connect CSB to AVDD, which disables the serial port interface.

Table 15. Mode Selection

| Pin | External Voltage | Configuration |
| :--- | :--- | :--- |
| SDIO | AVDD (default) | DCS enabled |
|  | AGND | DCS disabled |
| SCLK | AVDD | Twos complement enabled <br>  AGND (default) | | Offset binary enabled |
| :--- |

## SPI ACCESSIBLE FEATURES

Table 16 provides a brief description of the general features that are accessible via the SPI. These features are described in detail
in the AN-877 Application Note.

Table 16. Features Accessible Using the SPI

| Feature Name | Description |
| :--- | :--- |
| Power Modes | Allows the user to set either power-down mode or standby mode |
| Clock | Allows the user to access the DCS via the SPI |
| Offset | Allows the user to digitally adjust the converter offset |
| Test I/O | Allows the user to set test modes to have known data on output bits |
| Output Mode | Allows the user to set up outputs |
| Output Phase | Allows the user to set the output clock polarity |
| Output Delay | Allows the user to vary the delay of the clock derived from DCO $\pm$ |
| VREF | Allows the user to set the reference voltage |

## MEMORY MAP

## READING THE MEMORY MAP REGISTER TABLE

Each row in the memory map register table has eight bit locations. The memory map is roughly divided into three sections: the chip configuration registers (Address 0x00 to Address 0x02); the channel index and transfer registers (Address 0 x 05 and Address 0 xFF ); and the ADC functions registers, including setup, control, and test (Address 0x08 to Address $0 \times 4 \mathrm{FB}$ ).

The memory map register table (see Table 17) documents the default hexadecimal value for each hexadecimal address shown. The column with the heading Bit 7 (MSB) is the start of the default hexadecimal value given. For example, Address 0x09, the global clock register, has a hexadecimal default value of $0 \times 01$. This means that the LSB or Bit $0=1$, and the remaining bits are 0 s . This setting is the default output format value, which is twos complement. For more information on the functions controlled by Register 0x00 to Register 0x17, see the AN-877 Application Note. This application note also details the functions controlled by all remaining registers.

## Open and Reserved Locations

All address and bit locations that are not included in Table 17 are not currently supported for this device. Unused bits of a valid address location must be written with 0 s, unless otherwise noted. Writing to these locations is required only when part of an address location is open (for example, Address 0x18). If the entire address location is open/unused/undocumented (for example, Address 0x13), this address location must not be written.

## Default Values

After the AD9652 is reset, critical registers are loaded with default values. The default values for the registers are given in the memory map register table, Table 17.

## Logic Levels

An explanation of logic level terminology follows:

- "Bit is set" is synonymous with "bit is set to Logic 1 " or "writing Logic 1 for the bit."
- "Clear a bit" is synonymous with "bit is set to Logic 0 " or "writing Logic 0 for the bit."


## Transfer Register Map

The $0 \mathrm{x} 08,0 \mathrm{x} 0 \mathrm{D}, 0 \mathrm{x} 10,0 \mathrm{x} 14,0 \mathrm{x} 30$, and 0 x 45 to 0 x 4 C registers are shadowed. Writes to these addresses do not affect device operation until a transfer command is issued by writing $0 \times 01$ to Address 0 xFF , which sets the transfer bit. This allows these registers to be updated internally and simultaneously when the transfer bit is set. The internal update occurs when the transfer bit is set, and then the bit autoclears.

## Channel Specific Registers

Some channel setup functions, such as the signal monitor thresholds, can be programmed to a different value for each channel. In these cases, channel address locations are internally duplicated for each channel. These registers and bits are designated in Table 17 as local. These local registers and bits can be accessed by setting the appropriate Channel A or Channel B bits in Register $0 \times 05$. If both bits are set, the subsequent write affects the registers of both channels. In a read cycle, only Channel A or Channel B are set to read one of the two registers. If both bits are set during an SPI read cycle, the device returns the value for Channel A. Registers and bits designated as global in Table 17 affect the entire device and the channel features for which independent settings are not allowed. The settings in Register 0x05 do not affect the global registers and bits.

## MEMORY MAP REGISTER TABLE

All address and bit locations that are not included in Table 17 are not currently supported for this device.
Table 17. Memory Map Registers

| Addr <br> (Hex) | Register Name | Bit 7 <br> (MSB) | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | $\begin{aligned} & \text { Bit } 0 \\ & \text { (LSB) } \end{aligned}$ | Default Value (Hex) | Default Notes/ Comments |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Chip Configuration Registers |  |  |  |  |  |  |  |  |  |  |  |
| 0x00 | SPI port configuration $\left(\right.$ global) ${ }^{1}$ | 0 | LSB first | Soft reset | 1 | 1 | Soft reset | LSB first | 0 | 0x18 | The nibbles are mirrored so that LSB first mode or MSB first mode registers correctly, regardless of shift mode |
| 0x01 | Chip ID (global) | 8-Bit Chip ID[7:0], (AD9652 = 0xC1) (default) |  |  |  |  |  |  |  | 0xC1 | Read only |
| 0x02 | Chip grade (global) |  |  | $\begin{gathered} \text { Speed } \\ 0 \times 00 \end{gathered}$ | ade ID, fault |  |  |  |  | 0x00 | Speed grade ID differentiates devices; read only |
| Channel Index and Transfer Registers |  |  |  |  |  |  |  |  |  |  |  |
| 0x05 | Channel index (global) |  |  |  |  |  |  | Channel B (default) | Channel A (default) | 0x03 | Bits are set to determine which device on the chip receives the next write command; applies to local registers only |
| 0xFF | Transfer (global) |  |  |  |  |  |  |  | Transfer | 0x00 | Synchro- <br> nously transfers data from the master shift register to the slave |
| ADC Functions |  |  |  |  |  |  |  |  |  |  |  |
| 0x08 | Power modes (local) | Reserved, set to 1 |  | External powerdown pin function (local) $0=$ powerdown $1=$ standby |  |  |  | Internal power-down mode (local) <br> $00=$ normal operation <br> 01 = full power-down 10 = standby <br> 11 = reserved |  | 0x80 | Controls powerdown options |
| 0x09 | Global clock (global) |  |  |  |  |  |  |  | Enable DCS <br> (default) | 0x01 |  |

AD9652

| Addr <br> (Hex) | Register Name | $\begin{aligned} & \text { Bit } 7 \\ & \text { (MSB) } \end{aligned}$ | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | $\begin{aligned} & \text { Bit } 0 \\ & \text { (LSB) } \end{aligned}$ | Default Value (Hex) | Default <br> Notes/ <br> Comments |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0xOB | Clock divide (global) |  |  |  |  |  |  | $\begin{aligned} & \text { ck divi } \\ & 0=\operatorname{div} \\ & 1=\operatorname{div} \\ & \text { eservec } \\ & 1=\operatorname{div} \\ & 0=\operatorname{div} \end{aligned}$ | $\begin{aligned} & \text { io } \\ & 1 \\ & 2 \\ & 20 \text { use } \\ & 4 \\ & 8 \end{aligned}$ | 0x00 |  |
| 0x0D | Test mode (local) |  |  | Reset PN23 long gen PN23: $1+x^{17}+$ <br> $x^{22}$ | Reset PN9 short gen PN9: $1+x^{3}+x^{8}$ |  | $\begin{array}{r} 000 \\ 0001 \\ 00 \\ 00 \\ 00=\text { alt } \\ 0101= \\ 0110= \\ 111= \end{array}$ | st mod (defau scale s sitive gative g chec ng se ort sea word |  | 0x00 | When this register is set, the test data is placed on the output pins (D0 $\pm$ to D15 $\pm$ ) in place of normal data |
| 0xOF | Commonmode servo (global) |  |  |  |  |  |  |  | Enable commonmode servo | 0x00 |  |
| 0x10 | Offset adjust (local) | Offset adjust in LSBs from $+127(0111$ 1111) to $-128(10000000)$ (twos complement format) |  |  |  |  |  |  |  | 0x00 |  |
| 0x14 | Output mode (local) |  |  |  |  |  |  | ```Output format \(00=\) offset binary (default) \(01=\) twos complement \(10=\) gray code 11 = reserved``` |  | 0x00 | Configures the outputs and the format of the data |
| 0x15 | Output LVDS control (global) |  |  |  |  |  | $\begin{gathered} \hline \text { LVDS output drive current adjust } \\ 000=3.72 \mathrm{~mA} \text { (ANSI-LVDS, } \\ \text { default) } \\ 001=3.50 \mathrm{~mA} \\ 010=3.30 \mathrm{~mA} \\ 011=2.96 \mathrm{~mA} \\ 100=2.82 \mathrm{~mA} \\ 101=2.57 \mathrm{~mA} \\ 110=2.27 \mathrm{~mA} \\ 111=2.00 \mathrm{~mA} \text { (reduced swing } \\ \text { LVDS) } \end{gathered}$ |  |  | 0x00 |  |
| 0x16 | Clock phase adjust (global) |  |  |  |  |  | Input clock divider phase adjust $000=$ no delay <br> $001=1$ input clock cycle $010=2$ input clock cycle 011 = 3 input clock cycle $100=4$ input clock cycle $101=5$ input clock cycle $110=6$ input clock cycle 111 = 7 input clock cycle |  |  | 0x00 |  |
| 0x17 | DCO $\pm$ output delay (global) |  |  |  | DCO $\pm$ clock delay$($ Delay $=(2500 \mathrm{ps} \times$ register value $/ 31))$$00000=0 \mathrm{ps}$$00001=81 \mathrm{ps}$$00010=161 \mathrm{ps}$$\cdots$$11110=2419 \mathrm{ps}$$11111=2500 \mathrm{ps}$ |  |  |  |  | 0x00 |  |
| 0x18 | Input span select (global) | Reserved, set to 1 | Reserved, set to 1 |  |  |  | $V_{\text {REF }}$ select$\begin{gathered} 000=1.25 \mathrm{~V}(2.5 \mathrm{~V} \text { p-p input), default } \\ 001=1.125 \mathrm{~V}(2.25 \mathrm{Vp} \text { - } \text { input }) \\ 010=1.20 \mathrm{~V}(2.4 \mathrm{~V} \text { p-p input }) \\ 011=1.25 \mathrm{~V}(2.5 \mathrm{~V} \text { p-p input }) \\ 100=\text { do not use } \\ 101=1.0 \mathrm{~V}(2.0 \mathrm{~V} \text { p-p input }) \end{gathered}$ |  |  | 0xC0 |  |
| 0x30 | Dither (local) |  |  |  | Dither enable |  |  |  |  | 0x00 |  |

## AD9652

| Addr <br> (Hex) | Register Name | Bit 7 <br> (MSB) | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | $\begin{aligned} & \text { Bit } 0 \\ & \text { (LSB) } \end{aligned}$ | Default Value (Hex) | Default Notes/ Comments |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x45 | Fast detect (FD) control (local) |  |  |  |  |  |  |  | Enable fast detect output | 0x00 |  |
| 0x47 | FD upper threshold (local) |  |  |  |  | ```Fast Detect Upper Threshold[3:0] Valid programming range = 0x1 to 0x8 Threshold = midscale }\pm\mathrm{ (register value) }\times(1/8) (full scale)``` |  |  |  | 0x08 |  |
| 0x49 | FD lower threshold (local) | Fast Detect Lower Threshold[7:0] |  |  |  |  |  |  |  | 0x00 |  |
| 0x4A | FD lower threshold (local) |  | Fast Detect Lower Threshold[14:8] |  |  |  |  |  |  | $0 \times 02$ |  |
| 0x4B | FD dwell time (local) | Fast Detect Dwell Time[7:0] |  |  |  |  |  |  |  | 0x00 |  |
| 0x4C | FD dwell time (local) | Fast Detect Dwell Time[15:8] |  |  |  |  |  |  |  | 0x08 |  |
| 0x100 | SYNC control (global) |  |  |  |  |  | Clock divider next SYNC only | Clock divider SYNC enable | Master SYNC buffer enable | 0x00 |  |
| 0x212 | Dither gain (global) | 0b0000: 100\% dither applied 0b0001: 99.6\% dither applied 0b0010: 99.2\% dither applied 0b0011: 98.4\% dither applied 0b0100: 96.8\% dither applied 0b0101: 93.75\% dither applied 0b0110: 87.5\% dither applied 0b0111: 75\% dither applied 0b1000: 50\% dither applied |  |  |  | Reserved, set to 0 | Reserved, set to 0 | Reserved, set to 0 | Reserved, set to 0 | 0x08 |  |
| 0x22A | Input frequency settings (global) |  |  |  |  |  |  | 0 : fin in $1^{\text {st }}$ Nyquist <br> 1: $f_{\text {IN }}$ in $2^{\text {nd }}$ Nyquist <br> 2: fin in 3rd Nyquist or higher |  | $0 \times 00$ |  |
| 0x4FA | Calibration powerdown configuration (global) | Reserved, set to 0 | Reserved, set to 0 | Reserved, set to 0 | Reserved, set to 0 | Reserved, set to 0 | Reserved, set to 0 | Power down/standby initial calibration action: <br> 0b00: use previous calibration correction 0b11: initiate a fast calibration |  | $0 \times 03$ |  |
| 0x4FB | Calibration power-down configuration (global) | Reserved, set to 0 | Reserved, set to 0 | Reserved, set to 0 | Reserved, set to 0 | Reserved, set to 1 | Reset background calibration, set high then low | Reserved, set to 0 | Pause background calibration | 0x08 |  |

${ }^{1}$ Set the channel index register at Address $0 \times 05$ to $0 \times 03$ (default) when writing to Address $0 \times 00$.

## APPLICATIONS INFORMATION

## DESIGN GUIDELINES

Before starting system level design and layout of the AD9652, it is recommended that the designer become familiar with these guidelines, which describes the special circuit connections and layout requirements needed for certain pins.

## Power and Ground Recommendations

When connecting power to the AD9652, it is recommended that three separate power supplies be used. AVDD3 requires a 3.3 V supply, AVDD_CLK and AVDD require a 1.8 V supply, and DRVDD requires a 1.8 V supply. SPIVDD is typically connected to the same supply as DRVDD, but can be connected to a separate supply between 1.8 V and 3.3 V to ease the interface to the logic device that connects to the SPI pins (CLK, SDIO, and CSB).

The AVDD3 supply must be supplied from a clean 3.3 V power source. Decoupling must be a combination of PCB plane capacitance and decoupling capacitors to cover both high and low frequency noise sources. Typical capacitors of $0.1 \mu \mathrm{~F}$ and $1 \mu \mathrm{~F}$ near the AD9652 AVDD3 pins are advised.
The AVDD and AVDD_CLK supply connection must be powered up simultaneously to achieve proper on-chip biasing; therefore, it is recommended to connect the two supply voltages to a single source. Similar to the AVDD3 supply, decoupling must be a combination of PCB plane capacitance and decoupling capacitors to cover both high and low frequency noise sources. Typical capacitors of $0.1 \mu \mathrm{~F}$ and $1 \mu \mathrm{~F}$ near the AD9652 AVDD and AVDD_CLK pins is advised.
The DRVDD and SPIVDD supply connection must also have decoupling but these can be placed slightly further away from the AD9652. DRVDD and SPIVDD can be tied together for applications that can use a 1.8 V SPI interface logic. Optionally, SPIVDD can be driven with a supply of up to 3.3 V to support higher voltage logic interfaces.
Multiple large area PCB ground planes are recommended and provide many benefits. Low impedance power and ground planes are needed to maintain performance. Stacking power and ground planes in the PCB provides high frequency decoupling. Ground planes and thermal vias help dissipate heat generated by the device. With proper decoupling and smart partitioning of the PCB analog, digital, and clock sections, optimum performance is easily achieved.

## VCM

The VCM pin must be decoupled to ground with a $0.1 \mu \mathrm{~F}$ capacitor, as shown in Figure 54. For optimal channel-to-channel isolation, a $33 \Omega$ resistor must be included between the AD9652 VCM pin and the Channel A analog input network connection, as well as between the AD9652 VCM pin and the Channel B analog input network connection.

## RBIAS

The AD9652 requires that a $10 \mathrm{k} \Omega$ resistor be placed between the RBIAS pin and ground. This resistor sets the master current reference of the ADC core and must have at least a $1 \%$ tolerance.

## Reference Decoupling

Decouple the VREF pin externally to ground with a low ESR, $1.0 \mu \mathrm{~F}$ capacitor in parallel with a low ESR, $0.1 \mu \mathrm{~F}$ ceramic capacitor.

## SPI Port

The SPI port must not be active during periods when the full dynamic performance of the converter is required. Because the SCLK, CSB, and SDIO signals are typically asynchronous to the ADC clock, noise from these signals can degrade converter performance. If the on-board SPI bus is used for other devices, it may be necessary to provide buffers between this bus and the AD9652 to keep these signals from transitioning at the converter input pins during critical sampling periods.

## AD9652

## OUTLINE DIMENSIONS


*COMPLIANT WITH JEDEC STANDARDS MO-275-EEAA-1 WITH THE EXCEPTION TO BALL DIAMETER.

Figure 67. 144-Ball Chip Scale Package Ball Grid Array [CSP_BGA] (BC-144-6)
Dimensions shown in millimeters

ORDERING GUIDE

| Model $^{1}$ | Temperature Range | Package Description | Package Option |
| :--- | :--- | :--- | :--- |
| AD9652BBCZ-310 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $144-$-Ball Chip Scale Package Ball Grid Array [CSP_BGA] | BC-144-6 |
| AD9652BBCZRL7-310 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 144-Ball Chip Scale Package Ball Grid Array [CSP_BGA] | BC-144-6 |

${ }^{1} Z=$ RoHS Compliant Part.

## X-ON Electronics

Largest Supplier of Electrical and Electronic Components
Click to view similar products for Data Conversion IC Development Tools category:
Click to view products by Analog Devices manufacturer:
Other Similar products are found below :
EVAL-AD5063EBZ EVAL-AD5422LFEBZ EVAL-AD7265EDZ EVAL-AD7641EDZ EVAL-AD7674EDZ EVAL-AD7719EBZ EVAL-AD7767-1EDZ EVAL-AD7995EBZ AD9114-DPG2-EBZ AD9211-200EBZ AD9251-20EBZ AD9251-65EBZ AD9255-125EBZ AD9284250EBZ AD9613-170EBZ AD9627-125EBZ AD9629-20EBZ AD9709-EBZ AD9716-DPG2-EBZ AD9737A-EBZ AD9787-DPG2-EBZ AD9993-EBZ DAC8555EVM ADS5482EVM ADS8372EVM EVAL-AD5061EBZ EVAL-AD5062EBZ EVAL-AD5443-DBRDZ EVALAD5570SDZ EVAL-AD7450ASDZ EVAL-AD7677EDZ EVAL-AD7992EBZ EVAL-AD7994EBZ AD9119-MIX-EBZ AD9148-M5375EBZ AD9204-80EBZ AD9233-125EBZ AD9265-105EBZ AD9265-80EBZ AD9608-125EBZ AD9629-80EBZ AD9648-125EBZ AD964920EBZ AD9650-80EBZ AD9765-EBZ AD9767-EBZ AD9778A-DPG2-EBZ ADS8322EVM LM96080EB/NOPB EVAL-AD5445SDZ


[^0]:    ${ }^{1}$ Measured with a low input frequency, full-scale sine wave.
    ${ }^{2}$ Input capacitance refers to the effective capacitance between one differential input pin and AGND.
    ${ }^{3}$ Input resistance refers to the effective resistance between one differential input pin and AGND.
    ${ }^{4}$ Standby power is measured with a dc input and the CLK $\pm$ pins inactive (that is, set to AVDD or AGND).

[^1]:    ${ }^{1}$ Input capacitance/resistance refers to the effective capacitance/resistance between one differential input pin and AGND.
    ${ }^{2}$ Internal weak pull-up.
    ${ }^{3}$ Internal weak pull-down.

[^2]:    ${ }^{1}$ N/A means not applicable.
    ${ }^{2} \mathrm{~V}_{\text {REF }}$ is set via Register $0 \times 18$. The default $\mathrm{V}_{\text {REF }}$ is 1.25 V .

